

Search Notes	Application/Control No.	Applicant(s)/Patent under Reexamination
	10/500,612	SCHORLING, STEFAN
	Examiner	Art Unit
	Chuck Mah	3677

SEARCHED			
Class	Subclass	Date	Examiner
16	87.2		
	87R		
	94R		
	95R		
	96R		
	87B		
24	716		
	369-370		
248	215 *		
	340		
294	26		
	37.1		
223	85		
211	113, 106 106-1		
160	330, 126		

D8 367-368 11/15 0.1mm

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner